

Search Notes

Application/Control No.

10/716,149

Examiner

James D. Stein

Applicant(s)/Patent under
Reexamination

TOGAMI ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	24,53,88,9 2	5/19/2006	JDS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	5/19/2006	JDS
IEEE and INSPEC: optoelectronic, transceiver, host board, motherboard, daughter card, plurality	5/19/2006	JDS